

<b>Notice of References Cited</b>	Application/Control No. 10/643,041	Applicant(s)/Patent Under Reexamination LUH ET AL.	
	Examiner Dawn Garrett	Art Unit 1774	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,563,424	10-1996	Yang et al.	257/40
	B	US-5,281,489	01-1994	Mori et al.	428/690
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 07-325329 A	12-1995	Japan	Hamano et al.	---
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Parakka et al., Synthetic Metals, 68, (1995), pages 275-279.
	V	Hucke et al., J. Org. Chem. (1998), 63, p. 7413-7417.
	W	Bilik et al., Chembiochem, (2001), Vol. 2, pages 559-569.
	X	Adachi et al., Appl. Phys. Lett., 56 (9), 26 February 1990, p. 799-801.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.